

ATTY DOCKET NO.
214935US2PCTSERIAL NO.
09/926,335

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Hiroyuki FUKADAFILING DATE
October 23, 2001GROUP
2684

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,751,767	05/12/1998	Tatsumi Satoshi			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	EP 0884861 A2	12/16/1998	Europe (English Language)		
S. A.	AP	WO 94/18756 A	08/18/1994	WIPO (English Language)		
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Shaima Q. Lingrey

Date Considered 5-3-05

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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October 23, 2001

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2681

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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AUG 12 2003

Technology Center 2600

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
S.A.	AO	9-135215	05/20/97	JAPAN (with partial English translation)		X
S.A.	AP	1 096 711	05/02/2001	EUROPE		
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

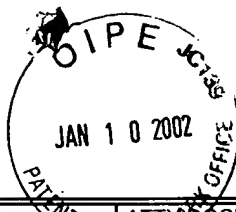
Examiner

Shaina A. Amis

Date Considered

3-2-04

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SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO.

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
S.A.	AO	WO 2000-02338	01/13/2000	WIPO		
	AP	1225529	08/11/99	CHINA		
	AQ	8-79161	03/22/96	JAPAN (submitting English Abstract only)		
	AR	8-223108	08/30/96	JAPAN (with English Abstract)		X
	AS	9-135215	05/20/97	JAPAN (with English Abstract)		X
	AT	11-220774	08/10/99	JAPAN (with English Abstract)		X
S.A.	AU	2000-22665	01/21/2000	JAPAN (with English Abstract)		X
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

Examiner

Shaina R. Armitage

Date Considered

3-2-04

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